

TOSHIBA Field Effect Transistor Silicon P/N-Channel MOS Type
(P-Channel/N-Channel Ultra-High-Speed U-MOSIII)

TPC8406-H

High Efficiency DC/DC Converter Applications

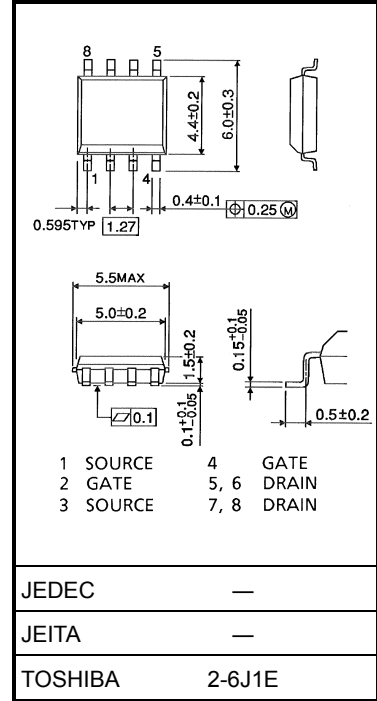
Notebook PC Applications

Portable Equipment Applications

CCFL Inverter Applications

- Small footprint due to a small and thin package
- High speed switching
- Low drain-source ON-resistance: P-Channel $R_{DS(ON)} = 24 \text{ m}\Omega$ (typ.)
N-Channel $R_{DS(ON)} = 22 \text{ m}\Omega$ (typ.)
- Small gate charge: P-Channel $Q_{SW} = 9.7 \text{ nC}$ (typ.)
N-Channel $Q_{SW} = 3.5 \text{ nC}$ (typ.)
- High forward transfer admittance: P-Channel $|Y_{fs}| = 13 \text{ S}$ (typ.)
N-Channel $|Y_{fs}| = 14 \text{ S}$ (typ.)
- Low leakage current: P-Channel $I_{DSS} = -10 \mu\text{A}$ ($V_{DS} = -40 \text{ V}$)
N-Channel $I_{DSS} = 10 \mu\text{A}$ ($V_{DS} = 40 \text{ V}$)
- Enhancement mode
: P-Channel $V_{th} = -0.8 \text{ to } -2.0 \text{ V}$ ($V_{DS} = -10 \text{ V}$, $I_D = -1 \text{ mA}$)
: N-Channel $V_{th} = 1.1 \text{ to } 2.3 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$)

Unit: mm



Weight: 0.085 g (typ.)

Absolute Maximum Ratings (Ta = 25°C)

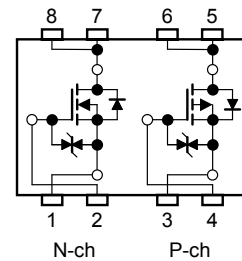
Characteristic	Symbol	Rating		Unit	
		P-Channel	N-Channel		
Drain-source voltage	V_{DSS}	-40	40	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	-40	40	V	
Gate-source voltage	V_{GSS}	± 20	± 20	V	
Drain current	DC (Note 1)	I_D	-6.5	6.5	A
	Pulse (Note 1)	I_{DP}	-26	26	
Drain power dissipation (t = 10s) (Note 2a)	Single-device operation (Note 3a)	$P_{D(1)}$	1.5	1.5	W
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	1.1	1.1	
Drain power dissipation (t = 10s) (Note 2b)	Single-device operation (Note 3a)	$P_{D(1)}$	0.75	0.75	W
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	0.45	0.45	
Single-pulse avalanche energy	E_{AS}	19 (Note 4a)	19 (Note 4b)	mJ	
Avalanche current	I_{AR}	-6.5	6.5	A	
Repetitive avalanche energy Single-device value at operation (Note 2a, 3b, 5)	E_{AR}	0.08		mJ	
Channel temperature	T_{ch}	150		°C	
Storage temperature range	T_{stg}	-55 to 150		°C	

Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

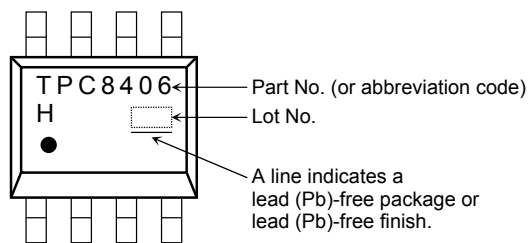
Circuit Configuration



Thermal Characteristics

Characteristic		Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device operation (Note 3a)	$R_{th} (ch-a) (1)$	83.3	°C/W
	Single-device value at dual operation (Note 3b)	$R_{th} (ch-a) (2)$	114	
Thermal resistance, channel to ambient (t = 10s) (Note 2b)	Single-device operation (Note 2a)	$R_{th} (ch-a) (1)$	167	
	Single-device value at dual operation (Note 2b)	$R_{th} (ch-a) (2)$	278	

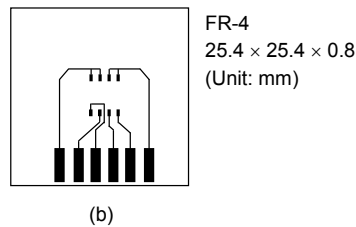
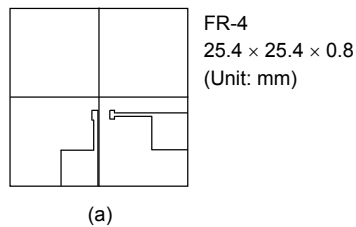
Marking



Note 1: The channel temperature should not exceed 150°C during use.

Note 2:

- a) Device mounted on a glass-epoxy board (a) b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is applied to one device only.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

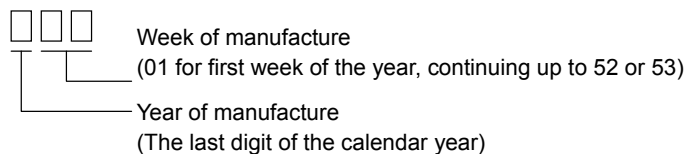
Note 4:

- a) $V_{DD} = -24\text{ V}$, $T_{ch} = 25^\circ\text{C}$ (Initial), $L = 0.5\text{ mH}$, $R_G = 25\ \Omega$, $I_{AR} = -6.5\text{ A}$
- b) $V_{DD} = 24\text{ V}$, $T_{ch} = 25^\circ\text{C}$ (Initial), $L = 0.5\text{ mH}$, $R_G = 25\ \Omega$, $I_{AR} = 6.5\text{ A}$

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

Note 6: • on the lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)



P-Channel Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$	—	—	± 10	μA
Drain cutoff current		I_{DSS}	$V_{DS} = -40\text{ V}, V_{GS} = 0\text{ V}$	—	—	-10	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = -10\text{ mA}, V_{GS} = 0\text{ V}$	-40	—	—	V
		$V_{(BR)DSX}$	$I_D = -10\text{ mA}, V_{GS} = 20\text{ V}$	-20	—	—	
Gate threshold voltage		V_{th}	$V_{DS} = -10\text{ V}, I_D = -1\text{ mA}$	-0.8	—	-2.0	V
Drain-source ON-resistance		$R_{DS(ON)}$	$V_{GS} = -4.5\text{ V}, I_D = -3.3\text{ A}$	—	29	37	m Ω
			$V_{GS} = -10\text{ V}, I_D = -3.3\text{ A}$	—	24	30	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = -10\text{ V}, I_D = -3.3\text{ A}$	6.5	13	—	S
Input capacitance		C_{iss}	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	1190	—	pF
Reverse transfer capacitance		C_{rSS}		—	170	—	
Output capacitance		C_{oss}		—	250	—	
Switching time	Rise time	t_r	<p>$V_{GS} = 0\text{ V}, -10\text{ V}$ $I_D = -3.3\text{ A}$ $R_L = 6.1\ \Omega$ $V_{DD} \approx -20\text{ V}$ $4.7\ \Omega$ V_{OUT} $Duty \leq 1\%, t_w = 10\ \mu\text{s}$</p>	—	5	—	ns
	Turn-on time	t_{on}		—	12	—	
	Fall time	t_f		—	12	—	
	Turn-off time	t_{off}		—	43	—	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -6.5\text{ A}$	—	27	—	nC
			$V_{DD} \approx -32\text{ V}, V_{GS} = -5\text{ V}, I_D = -6.5\text{ A}$	—	15	—	
Gate-source charge 1		Q_{gs1}	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -6.5\text{ A}$	—	3.2	—	
Gate-drain ("Miller") charge		Q_{gd}	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -6.5\text{ A}$	—	8.1	—	
Gate switch charge		Q_{sw}	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -6.5\text{ A}$	—	9.7	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	-26	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = -6.5\text{ A}, V_{GS} = 0\text{ V}$	—	—	1.2	V

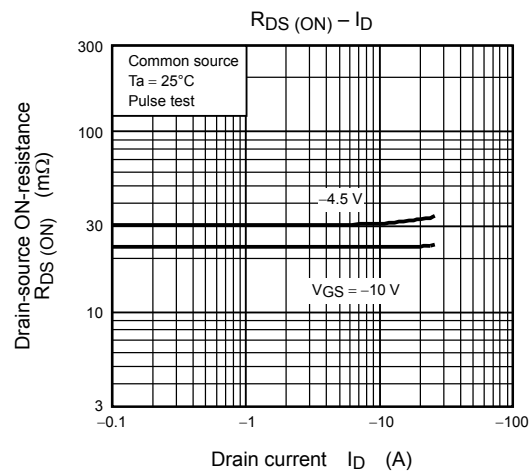
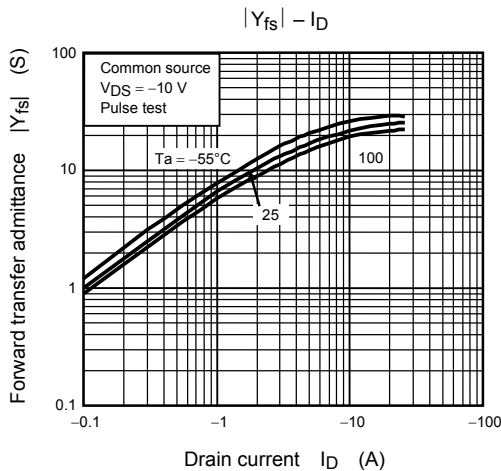
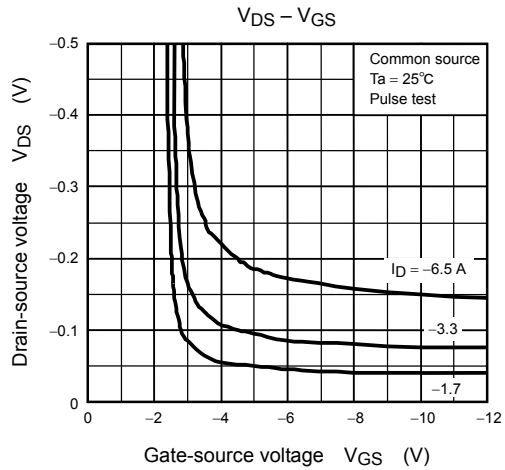
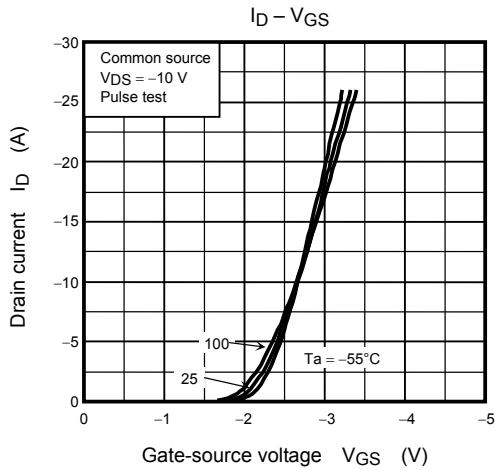
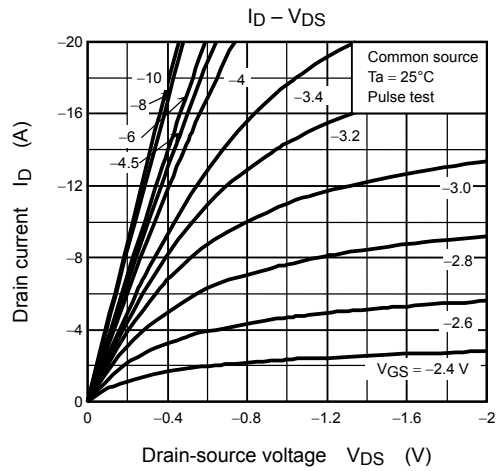
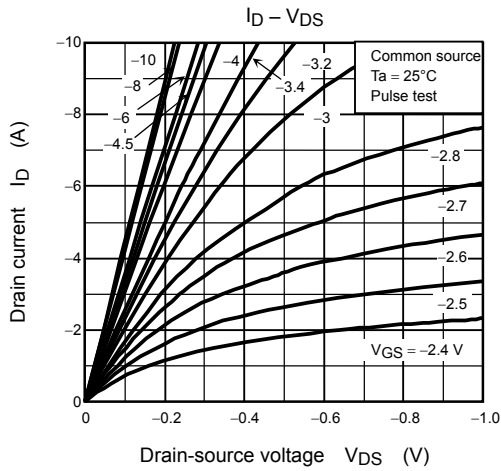
N-channel Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$	—	—	± 10	μA
Drain cutoff current		I_{DSS}	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$	—	—	10	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$	40	—	—	V
		$V_{(BR)DSX}$	$I_D = 10\text{ mA}, V_{GS} = -20\text{ V}$	25	—	—	
Gate threshold voltage		V_{th}	$V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$	1.1	—	2.3	V
Drain-source ON-resistance		$R_{DS(ON)}$	$V_{GS} = 4.5\text{ V}, I_D = 3.3\text{ A}$	—	27	35	m Ω
			$V_{GS} = 10\text{ V}, I_D = 3.3\text{ A}$	—	22	27	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10\text{ V}, I_D = 3.3\text{ A}$	7	14	—	S
Input capacitance		C_{iss}	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	650	—	pF
Reverse transfer capacitance		C_{rSS}		—	55	—	
Output capacitance		C_{oss}		—	240	—	
Switching time	Rise time	t_r	<p>$V_{GS} = 10\text{ V}$ 0 V $I_D = 3.3\text{ A}$ V_{OUT} $R_L = 6.1\ \Omega$ $V_{DD} \approx 20\text{ V}$</p>	—	3	—	ns
	Turn-on time	t_{on}		—	9	—	
	Fall time	t_f		—	2	—	
	Turn-off time	t_{off}		Duty $\leq 1\%$, $t_w = 10\ \mu\text{s}$	—	18	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx 32\text{ V}, V_{GS} = 10\text{ V}, I_D = 6.5\text{ A}$	—	11	—	nC
			$V_{DD} \approx 32\text{ V}, V_{GS} = 5\text{ V}, I_D = 6.5\text{ A}$	—	6.2	—	
Gate-source charge 1		Q_{gs1}	$V_{DD} \approx 32\text{ V}, V_{GS} = 10\text{ V}, I_D = 6.5\text{ A}$	—	2.1	—	
Gate-drain ("Miller") charge		Q_{gd}		—	2.7	—	
Gate switch charge		Q_{sw}		—	3.5	—	

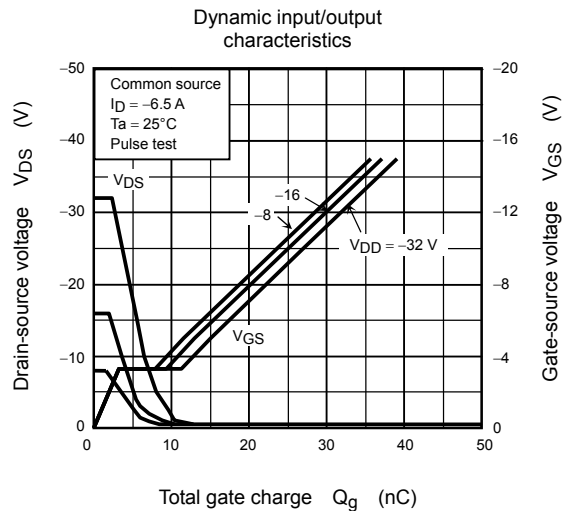
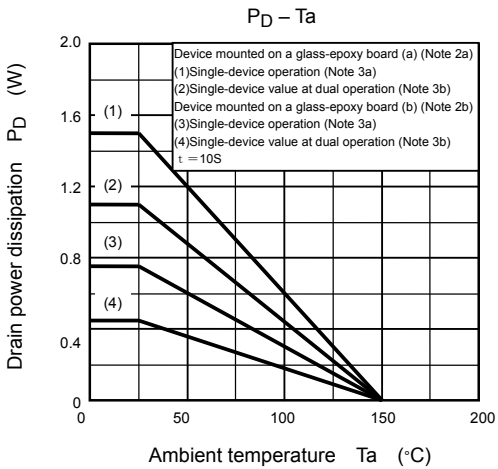
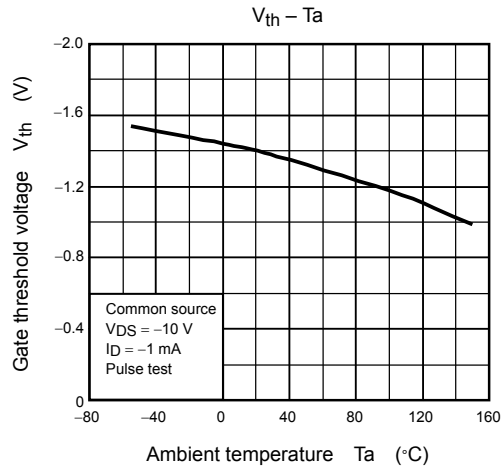
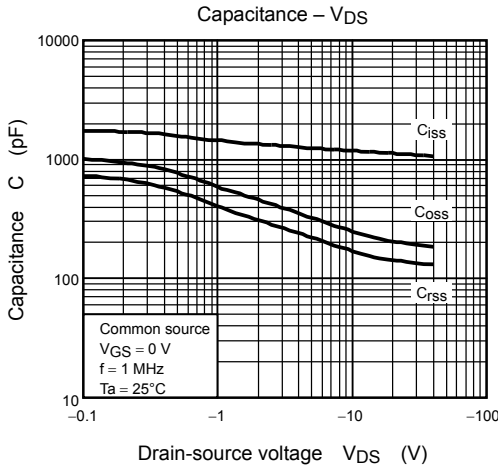
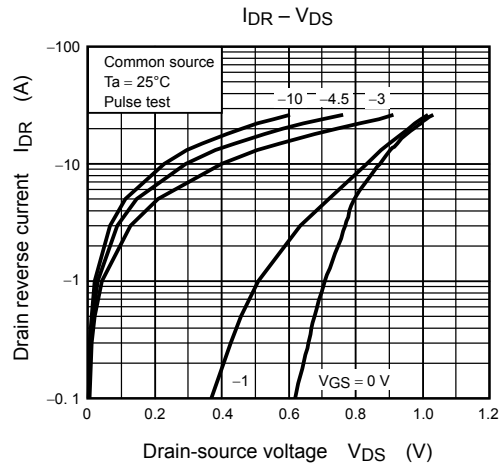
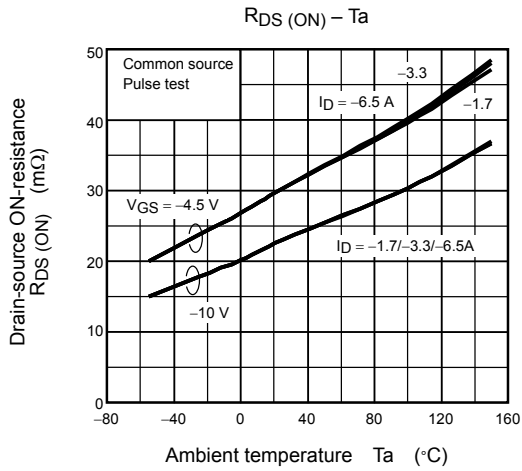
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	26	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = 6.5\text{ A}, V_{GS} = 0\text{ V}$	—	—	-1.2	V

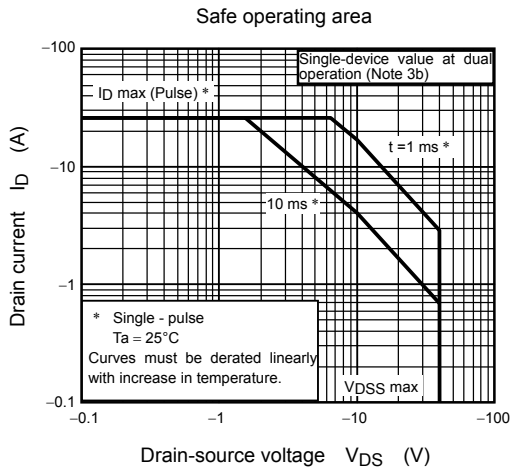
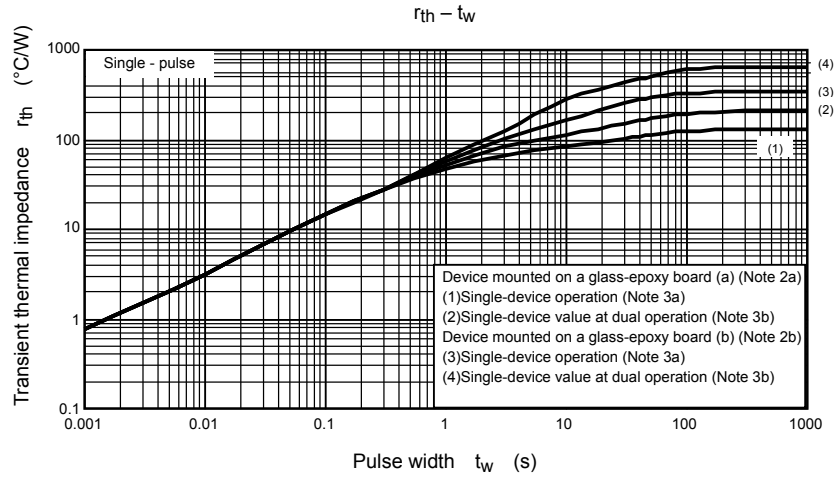
P-Channel



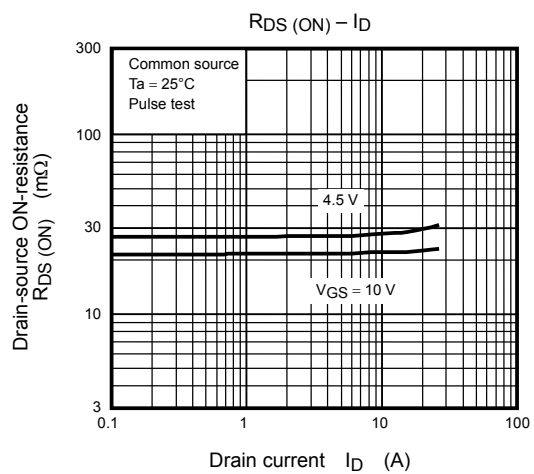
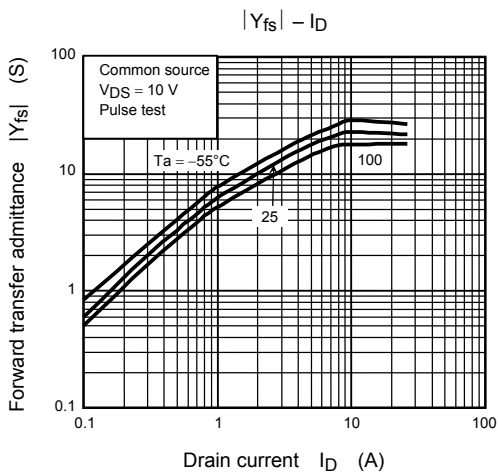
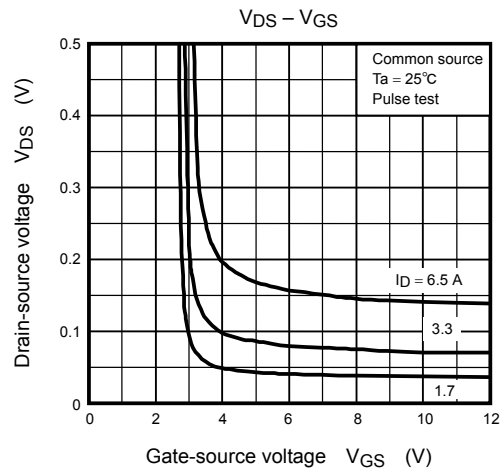
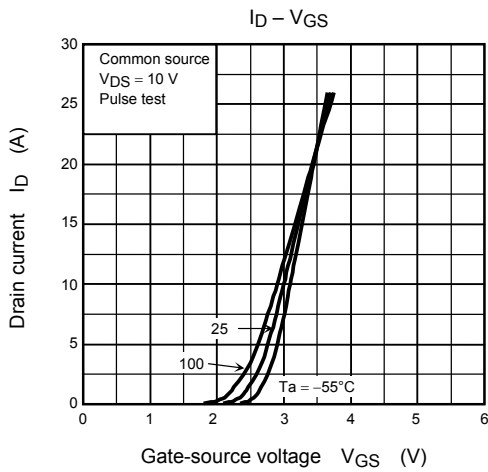
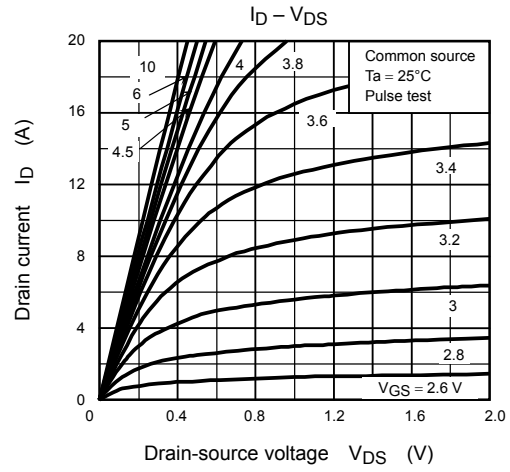
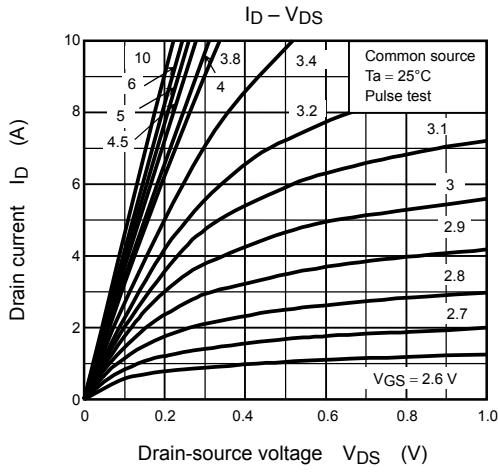
P-Channel



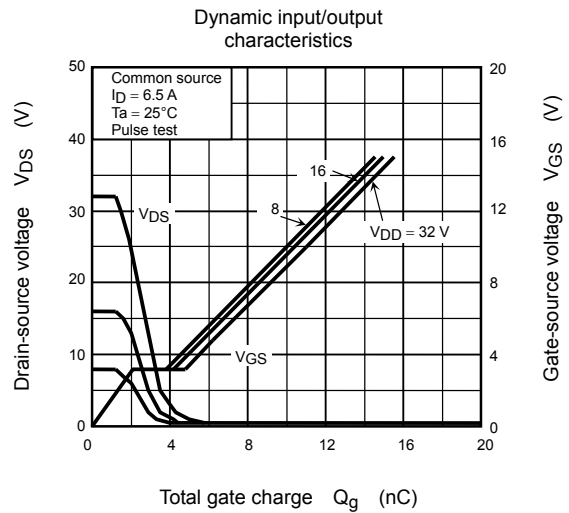
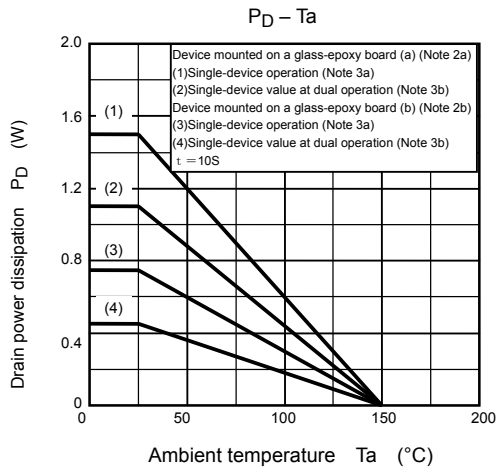
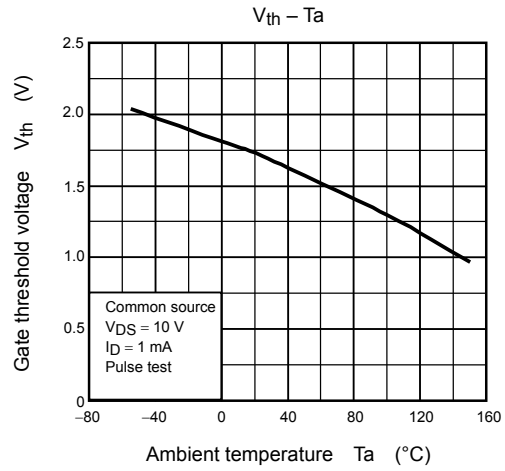
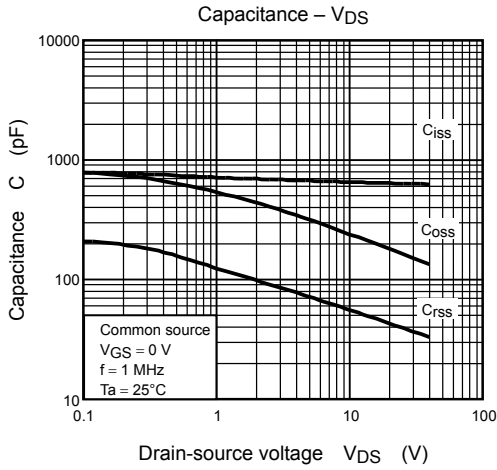
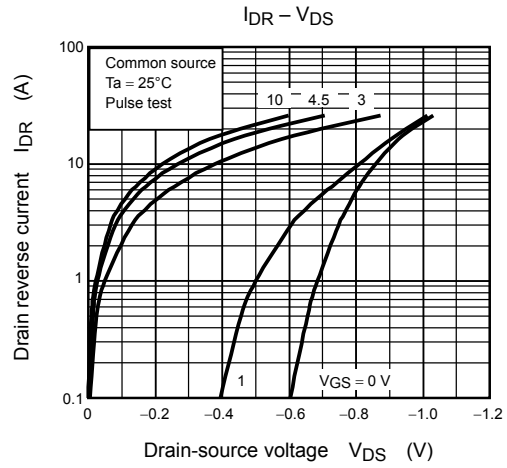
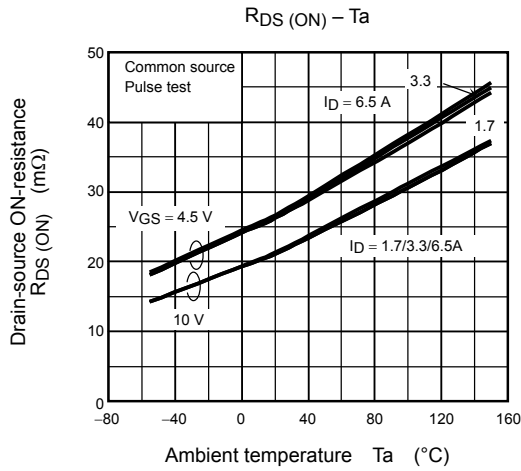
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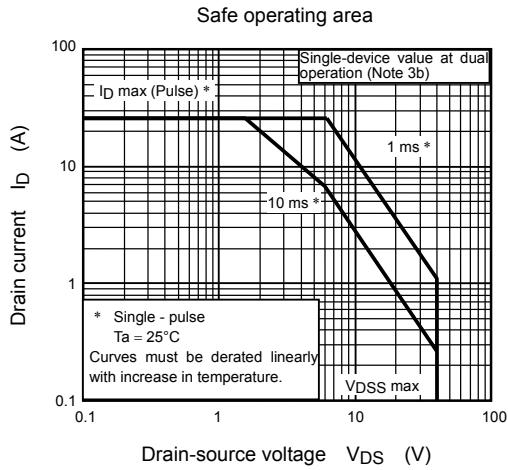
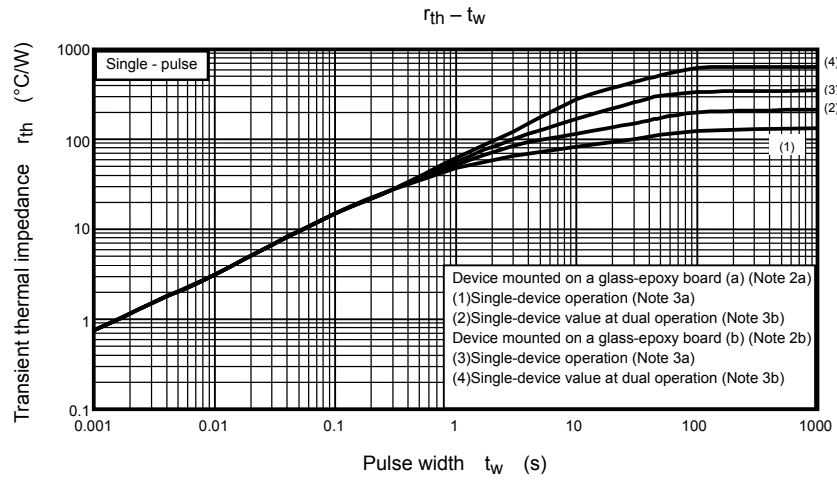
N-Channel



N-Channel



N-Channel



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